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+3.3V, 2.5Gbps, SDH/SONET 16:1 Serializer with Clock Synthesis and LVDS Inputs

General Description

The MAX3890 serializer is ideal for converting 16-bitwide, 155Mbps parallel data to 2.5Gbps serial data in ATM and SDH/SONET applications. Operating from a single +3.3V supply, this device accepts low-voltage differential-signal (LVDS) clock and data inputs for interfacing with high-speed digital circuitry, and delivers positive-referenced emitter-coupled logic (PECL) serial data and clock outputs. A fully integrated phaselocked loop (PLL) synthesizes an internal 2.5GHz serial clock from a 155.52MHz, 77.76MHz, 51.84MHz, or 38.88MHz reference clock. A loopback data output is provided to facilitate system diagnostic testing.

The MAX3890 is available in the extended temperature range (-40°C to +85°C) in a 64-pin TQFP exposed-pad (EP) package.

Applications

2.5Gbps SDH/SONET Transmission Systems 2.5Gbps ATM/SONET Access Nodes Add/Drop Multiplexers Digital Cross-Connects ATM Backplanes

Features

- ♦ Single +3.3V Supply
- **♦ 495mW Power Consumption**
- ♦ Exceeds ANSI, ITU, and Bellcore Specifications
- ♦ 155Mbps (16-bit wide) Parallel to 2.5Gbps Serial Conversion
- ♦ Clock Synthesis for 2.5Gbps
- **♦ Multiple Clock Reference Frequencies** (155.52MHz, 77.76MHz, 51.84MHz, 38.88MHz)
- **♦ LVDS Parallel Clock and Data Inputs**
- ◆ Additional High-Speed Output for System **Loopback Testing**

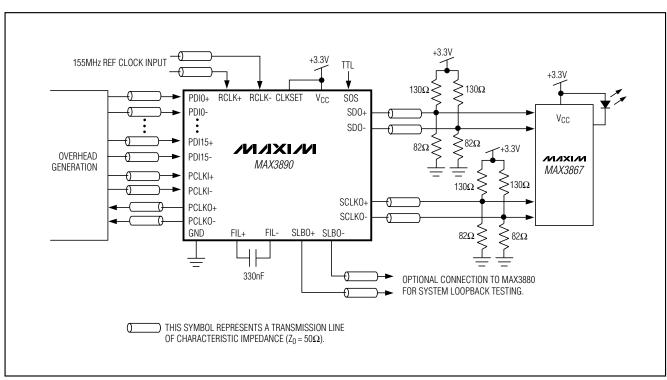
Ordering Information

PART	TEMP. RANGE	PIN-PACKAGE
MAX3890ECB	-40°C to +85°C	64 TQFP-EP*

^{*}EP = Exposed pad

Pin Configuration appears at end of data sheet.

Typical Operating Circuit



MIXIM

Maxim Integrated Products 1

ABSOLUTE MAXIMUM RATINGS

Terminal Voltage (with respect to GND) VCC0.5V to +5V All Inputs, FIL+, FIL0.5V to (VCC + 0.5V) Output Current	Continuous Power Dissipation (T _A = +85°C) TQFP-EP (derate 44.8mW/°C above +85°C)1W Operating Temperature Range40°C to +85°C Storage Temperature Range60°C to +150°C
LVDS Outputs (PCLKO±) 10mA PECL Outputs (SDO±, SCLKO±) 50mA CML Outputs (SLBO±) 15mA	Lead Temperature (soldering, 10s)+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

DC ELECTRICAL CHARACTERISTICS

 $(V_{CC} = +3.0 \text{V to } +3.6 \text{V}, \text{ differential LVDS loads} = 100\Omega \pm 1\%, \text{ PECL loads} = 50\Omega \pm 1\% \text{ to } (V_{CC} - 2 \text{V}), \text{ CML loads} = 50\Omega \pm 1\% \text{ to } V_{CC}, \text{ T}_{A} = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}, \text{ unless otherwise noted.}$ Typical values are at $V_{CC} = +3.3 \text{V}, \text{ T}_{A} = +25 ^{\circ}\text{C}.)$

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Supply Current	Icc	PECL outputs unterminated, SOS = low		150	230	mA
PECL OUTPUTS (SDO±, SCLKO±)			'		'	
Output Voltage High	1/0	$T_A = 0$ °C to +85°C	Vcc - 1.0)25 V	/CC - 0.88	V
Output Voltage Flight	Voh	T _A = -40°C	V _{CC} - 1.0)85 V	/CC - 0.88	V
Output Voltage Low	V _{OL}	$T_A = 0$ °C to +85°C	V _{CC} - 1.8	31 V	CC - 1.62	V
Output voltage Low	VOL	T _A = -40°C	Vcc -1.8	3 V	CC - 1.555	1 V
LVDS INPUTS AND OUTPUTS (PCLK	O±, PDI_±,	PCLKI±, RCLKI±)				
Input Voltage Range	VI	Differential input voltage = 100mV	0		2.4	V
Differential Input Threshold	VIDTH		-100		100	mV
Threshold Hysteresis	VHYST			60		mV
Differential Input Resistance	RIN		85	100	115	Ω
Output Voltage High	VoH				1.475	V
Output Voltage Low	Vol		0.925			V
Differential Output Voltage	Vod	Figure 5	250		400	mV
Change in Magnitude of Differential Output Voltage for Complementary States	Δ V _{OD}				±25	mV
Output Offset Voltage	Vos		1.125		1.275	V
Change in Magnitude of Output Offset Voltage for Complementary States	ΔV _{OS}				±25	mV
Single-Ended Output Resistance	Ro		40	95	140	Ω
Change in Magnitude of Single-Ended Output Resistance for Complementary Outputs	ΔR _O			±2.5	±10	%

DC ELECTRICAL CHARACTERISTICS (continued)

 $(V_{CC} = +3.0 \text{V to } +3.6 \text{V}, \text{ differential LVDS loads} = 100\Omega \pm 1\%, \text{ PECL loads} = 50\Omega \pm 1\% \text{ to } (V_{CC} - 2 \text{V}), \text{ CML loads} = 50\Omega \pm 1\% \text{ to } V_{CC}, \text{ TA} = -40^{\circ}\text{C to } +85^{\circ}\text{C}, \text{ unless otherwise noted. Typical values are at } V_{CC} = +3.3 \text{V}, \text{ TA} = +25^{\circ}\text{C}.)$

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
PROGRAMMING INPUT (CLKSET)	•					
CLKSET Input Current	ICLKSET	CLKSET = 0 or V _{CC}			±500	μΑ
TTL INPUT (SOS)	•					
Input Voltage High	VIH		2.0			V
Input Voltage Low	VIL				0.8	V
Input Current High	lін		-10		10	μΑ
Input Current Low	lıL		-10		10	μΑ
CURRENT MODE LOGIC (CML) OU	TPUTS (SLBC)±)				
Differential Output Voltage	IVodl		100		400	mV
Single-Ended Output Resistance	Ro			50		Ω

AC ELECTRICAL CHARACTERISTICS

 $(V_{CC} = +3.0 \text{V to } +3.6 \text{V}, \text{ differential LVDS load} = 100\Omega \pm 1\%, \text{ PECL loads} = 50\Omega \pm 1\% \text{ to } (V_{CC} - 2 \text{V}), \text{ CML loads} = 50\Omega \pm 1\% \text{ to } V_{CC}, \text{ TA} = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}, \text{ unless otherwise noted.}$ Typical values are at $V_{CC} = +3.3 \text{V}, \text{ TA} = +25 ^{\circ}\text{C}.)$ (Note 1)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Serial Clock Rate	fsclk			2.488		GHz
Parallel Data Setup Time	tsu	(Note 2)	300			ps
Parallel Data-Hold Time	tH	(Note 2)	700			ps
PCLKO to PCLKI Skew	tskew	Figure 2	0		+4.0	ns
Output Jitter Generation (SCLKO±)	Φ0	Jitter bandwidth = 12kHz to 20MHz, RCLK amplitude > VIDTH (Note 3)			3	ps _{RMS}
PECL Differential Output Rise/Fall Time	t _R , t _F	20% to 80%			120	ps
Parallel Input Clock Rate	fPCLKI			155.52		MHz
Reference Clock Input (RCLKI) Rise/Fall Time	t _R , t _F	20% to 80%, f = 155.52MHz			1.0	ns
Parallel Clock Output (PCLKO) Rise/Fall Time	t _R , t _F	20% to 80%			1.0	ns
Serial Clock Output (SCLKO) to Serial-Data Output (SDO) Delay	tsclk-sd	SCLKO rising edge to SDO edge	110		290	ps

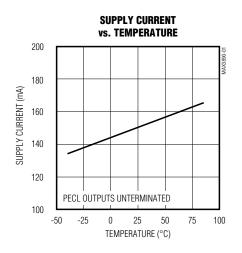
Note 1: AC characteristics guaranteed by design and characterization.

Note 2: Setup and hold times are relative to the rising edge of PCLKI+, measured by applying a 155.52MHz differential parallel clock with rise/fall time = 1ns (20% to 80%). See Figure 2.

Note 3: For $f_{RCLK} = 38.88MHz$, the minimum reference clock amplitude is $\geq 200 \text{mV}$.

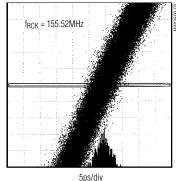
Typical Operating Characteristics

(V_{CC} = +3.3V, PECL loads = $50\Omega \pm 1\%$, T_A = +25°C, unless otherwise noted.)

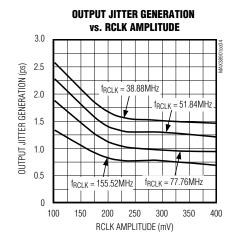


SERIAL-DATA OUTPUT EYE DIAGRAM OUTPUT EYE DIAGRAM SOBONI

SERIAL-DATA OUTPUT JITTER



TOTAL WIDEBAND RMS JITTER = 2.155ps PEAK-TO-PEAK JITTER = 15.7ps



Pin Description

PIN	NAME	FUNCTION
1, 17, 33, 48, 49, 63	GND	Ground
2, 5, 7, 10, 13, 14, 32, 56, 60, 64	Vcc	+3.3V Supply Voltage
3	SLBO-	System Loopback Inverting Output. Enabled when SOS is high.
4	SLBO+	System Loopback Noninverting Output. Enabled when SOS is high.
6	SOS	System Loopback Output Select. System loopback disabled when low.
8	SCLKO-	Inverting PECL Serial Clock Output
9	SCLKO+	Noninverting PECL Serial Clock Output
11	SDO-	Inverting PECL Serial-Data Output
12	SDO+	Noninverting PECL Serial-Data Output
15	PCLKI+	Noninverting LVDS Parallel Clock Input. Connect the incoming parallel-clock signal to the PCLKI inputs. Note that data is updated on the positive transition of the PCLKI signal.
16	PCLKI-	Inverting LVDS Parallel Clock Input. Connect the incoming parallel-clock signal to the PCLKI inputs. Note that data is updated on the positive transition of the PCLKI signal.
18, 20, 22, 24, 26, 28, 30, 34, 36, 38, 40, 42, 44, 46, 50, 52	PDI15+ to PDI0+	Noninverting LVDS Parallel Data Inputs. Data is clocked on the PCLKI positive transition.
19, 21, 23, 25, 27, 29, 31, 35, 37, 39, 41, 43, 45, 47, 51, 53	PDI15- to PDI0-	Inverting LVDS Parallel Data Inputs. Data is clocked on the PCLKI positive transition.
54	PCLKO+	Noninverting LVDS Parallel Clock Output. Use positive transition of PCLKO to clock the overhead management circuit.
55	PCLKO-	Inverting LVDS Parallel Clock Output. Use positive transition of PCLKO to clock the overhead management circuit.
57	RCLK+	Noninverting LVDS Reference Clock Input. Connect an LVDS-compatible crystal reference clock to the RCLK inputs.
58	RCLK-	Inverting LVDS Reference Clock Input. Connect an LVDS-compatible crystal reference clock to the RCLK inputs.
59	CLKSET	Reference Clock Rate Programming Pin: CLKSET = V_{CC} : Reference Clock Rate = 155.52MHz CLKSET = Open: Reference Clock Rate = 77.76MHz CLKSET = $20k\Omega$ to GND: Reference Clock Rate = 51.84 MHz CLKSET = GND: Reference Clock Rate = 38.88 MHz
61	FIL-	Filter Capacitor Input. Connect a 330nF capacitor between FIL+ and FIL
62	FIL+	Filter Capacitor Input. Connect a 330nF capacitor between FIL+ and FIL
EP	Exposed Pad	Ground. This must be soldered to a circuit board for proper thermal performance (see <i>Package Information</i>).

Detailed Description

The MAX3890 converts 16-bit-wide, 155Mbps data to 2.5Gbps serial data (Figure 1). It is composed of a 16-bit parallel input register, a 16-bit shift register, control and timing logic, PECL output buffers, LVDS input/output buffers, and a frequency-synthesizing PLL (consisting of a phase/frequency detector, loop filter/amplifier, voltage-controlled oscillator (VCO), and prescaler).

The PLL synthesizes an internal 2.5Gbps reference used to clock the output shift register. This clock is generated by locking onto the external 155.52MHz, 77.76MHz, 51.84MHz, or 38.88MHz reference-clock signal (RCLK).

The incoming parallel data is clocked into the MAX3890 on the rising transition of the parallel-clock-input signal (PCLKI). Proper operation is ensured if the parallel input register is latched within a window of time

(tskew) that is defined with respect to the parallel-clock-output signal (PCLKO). PCLKO is the synthesized 2.5Gbps internal serial-clock signal divided by 16. The allowable PCLKO-to-PCLKI skew is 0 to +4ns. This defines a timing window after the PCLKO rising edge, during which a PCLKI rising edge may occur (Figure 2).

System Loopback

The MAX3890 is designed to allow system loopback testing. The loopback outputs (SLBO+, SLBO-) of the MAX3890 may be directly connected to the loopback inputs of a deserializer (such as the MAX3880) for system diagnostics. To enable the SLBO outputs, apply a TTL logic-high signal to the SOS input. **Note:** The same signal that controls the SOS enable input may also be used to control the SIS enable input on the MAX3880.

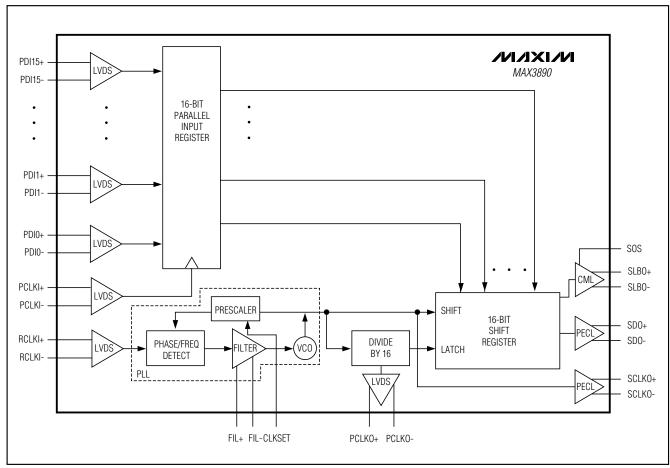


Figure 1. Functional Diagram

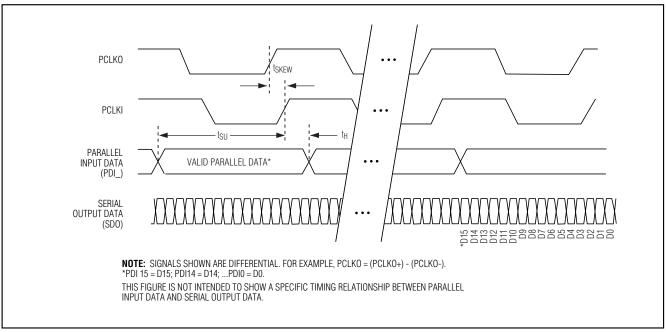


Figure 2. Timing Diagram

Low-Voltage Differential-Signal Inputs and Outputs

The MAX3890 has LVDS inputs and outputs for interfacing with high-speed digital circuitry. The LVDS standard is based on the IEEE 1596.3 LVDS specification. This technology uses 250mV to 400mV differential low-voltage swings to achieve fast transition times, minimized power dissipation, and noise immunity.

For proper operation, the parallel clock LVDS outputs (PCLKO+, PCLKO-) require 100Ω differential DC termination between the inverting and noninverting outputs. Do not terminate these outputs to ground.

The parallel data and parallel clock LVDS inputs (PDI_+, PDI_-, PCLKI+, PCLKI-, RCLK+, RCLK-) are

internally terminated with 100Ω differential input resistance, and therefore do not require external termination.

PECL Outputs

The serial-data PECL outputs (SDO+, SDO-, SCLKO+, SCLKO-) require 50Ω DC termination to (V_{CC} - 2V) (see the *Alternative PECL-Output Termination* section).

Current-Mode Logic Outputs

The system loopback outputs (SLBO+, SLBO-) of the MAX3890 are designed using CML. The configuration of the MAX3890 current-mode logic (CML) output circuit includes internal 50Ω back termination to VCC (Figure 3). These outputs are intended to drive a 50Ω transmission line terminated with a matched load impedance.

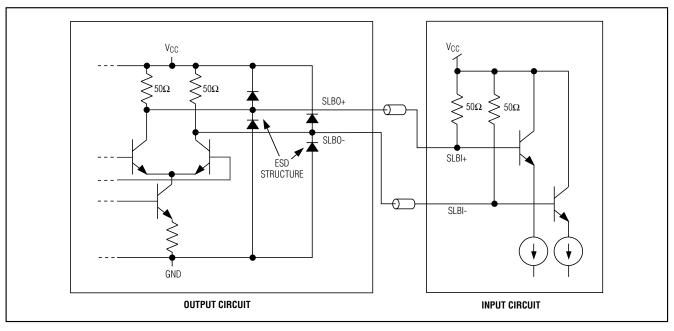


Figure 3. Current-Mode Logic

Applications Information

Alternative PECL-Output Termination

Figure 4 shows alternative PECL-output termination methods. Use Thevenin-equivalent termination when a (V_{CC} - 2V) termination voltage is not available. If AC-coupling is necessary, be sure that the coupling capacitor is placed following the 50Ω or Thevenin-equivalent DC termination.

Layout Techniques

For best performance, use good high-frequency layout techniques. Filter voltage supplies and keep ground connections short. Use multiple vias where possible. Also, use controlled-impedance transmission lines to interface with the MAX3890 clock and data inputs and outputs.

Exposed Pad (EP) Package

The EP 64-pin TQFP incorporates features that provide a very low thermal resistance path for heat removal from the IC to a PC board. The MAX3890's exposed pad must be soldered directly to a ground plane with good thermal conductance.

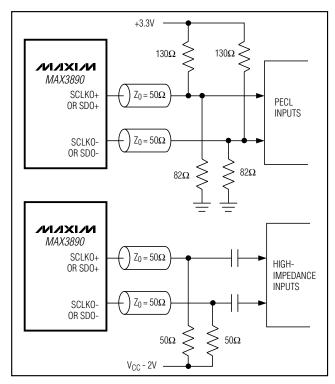


Figure 4. Alternative PECL-Output Termination

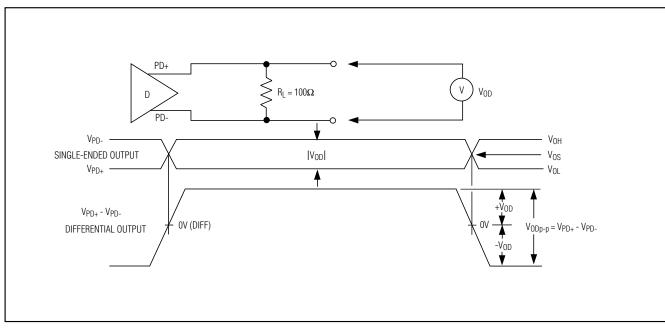
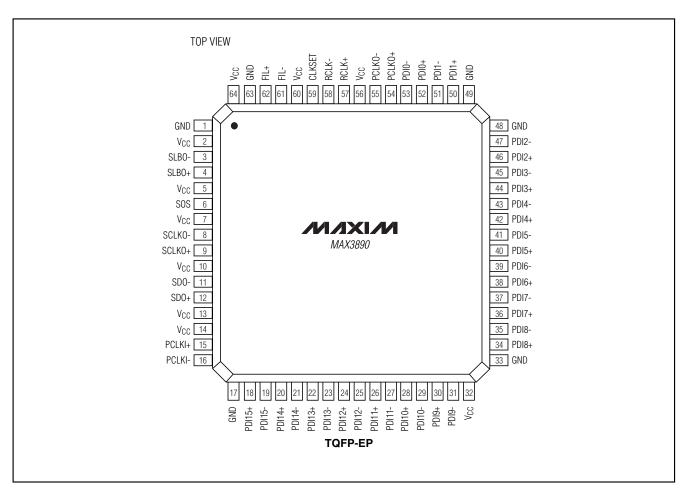


Figure 5. Driver Output Levels

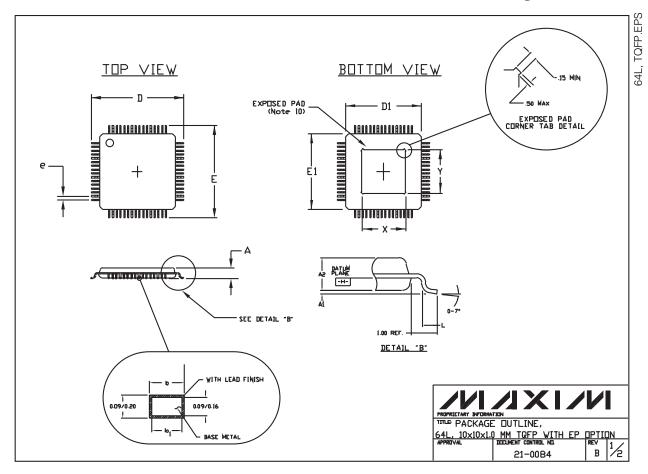
Pin Configuration



Chip Information

TRANSISTOR COUNT: 4126

Package Information



Package Information (continued)

- NOTES:

 1. ALL DIMENSIONS AND TOLERANCING CONFORM TO ANSI Y14.5-1982.

 2. DATUM PLANE _H=_ IS LOCATED AT MOLD PARTING LINE AND COINCIDENT WITH LEAD, WHERE LEAD EXITS PLASTIC BODY AT BOTTOM OF PARTING LINE.

 3. DIMENSIONS DI AND EL OD HOT INCLUDE MOLD PROTRUSION.
 ALLOWABLE MOLD PROTRUSION IS 0.254 MM ON DI AND EL DIMENSIONS.

 4. THE TOP OF PACKAGE IS SMALLER THAN THE BOTTOM OF PACKAGE BY 0.15 MILLIMETERS.

 5. DIMENSION 6 DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 MM TOTAL IN EXCESS OF THE 6 DIMENSION AT MAXIMUM MATERIAL CONDITION.

 6. CONTROLLING DIMENSION: MILLIMETER.

 7. THIS DUTLINE CONFORMS TO JEDEC PUBLICATION 95 REGISTRATION MO-136, VARIATION AJ.

 8. LEADS SHALL BE COPLANAR WITHIN 004 INCH.

 9. EXPOSED DIE PAD SHALL BE COPLANAR WITH BOTTOM OF PACKAGE WITHIN 2 MILS (.05 MM).

 10. DIMENSIONS X & Y APPLY TO EXPOSED PAD (EP) VERSIONS DNLY. SEE INDIVIDUAL PRODUCT DATASHEET TO DETERMINE IF A PRODUCT USES EXPOSED PAD PACKAGE.

s	JEDEC VARIATION ALL DIMENSIONS IN MILLIMETERS						
S Y M B	LA LUMENSIONS IN MILLIMETE						
lä	<u> </u>						
ī	MIN.	MAX.					
Α	74	1.20					
A ₁	0.05	0.15					
A2	0.95	1.05					
D	12.00 BSC.						
D ₁	10.00 BSC.						
Ε	12.00 BSC.						
Εį	10.00 BSC.						
L	0.45	0.75					
Ŋ	64						
e	0.50 BSC.						
ь	0.17	0.27					
юÍ	0.17	0.23					
×χ	4.7	5.30					
₩Y	4.70	5.30					
	·	* EXPOSED PAD (Note 10)					



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